Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/644,579	SANCHEZ ET AL.	
Examiner	Art Unit	
Yong S. Chong	1617	

SEARCHED					
Class	Subclass	Date	Examiner		
514	469	6/15/2005	YSC		
558	422	6/15/2005	YSC		
Updated	Search	1/24/06	YSC		
Updated Updated	Dearch	f/2 <del>\$</del> /06	YSL		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
7				

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Inventor (PALM, EAST)	6/15/2005	YSC		
Text (EAST, STN)	6/15/2005	YSC		
Updated Search	1/24/06	·4sc		
updated Search	A/20/00	452		
10.				